TRA	NSMITTA	AL OF INFORMA (Under 37 CFF	Docket No. OKI.206D3							
In Re Application Of: Masahiro Yoshida et al. 2 1 2004 51										
Appli	ication No.	Filing Date	Examiner Examiner	Customer No.	Group Art Unit	Confirmation No.				
10	/762,361	January 23, 2004	W. Lindsay, Jr.		2812	4915				
Title:	Title: METHOD OF MANUFACTURING A SEMICONDUCTOR DEVICE INCLUDING A MOSFET WITH NITRIDE SIDEWALLS									
	Address to:  Commissioner for Patents  P.O. Box 1450  Alexandria, VA 22313-1450									
			37 CFR 1.97(b)							
1. 🛚	1.   The Information Disclosure Statement submitted herewith is being filed within three months of the filing of a national application other than a continued prosecution application under 37 CFR 1.53(d); within three months of the date of entry of the national stage as set forth in 37 CFR 1.491 in an international application; before the mailing of a first Office Action on the merits, or before the mailing of a first Office Action after the filing of a request for continued examination under 37 CFR 1.114.									
2. 🗆	37 CFR 1.97(c)  2. □ The Information Disclosure Statement submitted herewith is being filed after the period specified in 37 CFR 1.97(b), provided that the Information Disclosure Statement is filed before the mailing date of a Final Action under 37 CFR 1.113, a Notice of Allowance under 37 CFR 1.311, or an Action that otherwise closes prosecution in the application, and is accompanied by one of:									
	☐ the statement specified in 37 CFR 1.97(e);									
OR										
	☐ the f	fee set forth in 37 CF	R 1.17(p).							

TRANSMITTAL OF INFORMATION DISCLOSURE STATEMENT (Under 37 CFR 1.97(b) 1.97(c)						Docket No. OKI.206D3			
In Re Application: Masahiro Yoshida et al. OCT 2 1 2004									
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Payment of Fee  (Only complete if Applicant elects to pay the fee set forth in 37 CFR 1.17(p))  A check in the amount of is attached.  The Director is hereby authorized to charge and credit Deposit Account No. 50-0238 as described below.  Charge the amount of Credit any overpayment.  Charge any additional fee required.  Payment by credit card. Form PTO-2038 is attached.  WARNING: Information on this form may become public. Credit card information should not be included on this form. Provide credit card information and authorization on PTO-2038.  Certificate of Transmission by Facsimile*  Certificate of Mailing by First Class Mail  I certify that this document and authorization to charge deposit account is being facsimile transmitted to the United States Patent and Trademark Office (Fax. No.  (Date)									
Signature Signature of Person Mailing Correspondence						ndence			
Typed or Printed Name of Person Signing Certificate  Typed or Printed Name of Person Mailing Ce						ertificate			
*This certificate may only be used if paying by deposit account.  Dated: October 21, 2004  ANDREW J. TELESZ, JR.  REG. NO. 33,581									
ONE 1 11951 REST	FREEDOM S	ORIVE, SUITE 1260	L.L.C.						

INFORMATION DISCLOSURE CITATION				Docket Number (Optional) OKI.206D3 Applicant(s)		Application Number 10/762,361				
		(Use several sheets if nec			Masahiro Yoshida	et al.				
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			PRADEMANN SE U.S.	. PATENT	DOCUMENTS	_				
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EXAMINER					DATE CONSIDERED					
		l if citation considered, wheth lude copy of this form with n			ce with MPEP Section 60	99; Draw line thro	ough citation if no	ot in conform	ance and	